## Application/Control No. Applicant(s)/Patent Under Reexamination 09/307,187 FRIEDLAND ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 3623 Susanna M. Diaz **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D Ε US-US-F US-G US-Н USı J US-US-Κ US-L US-FOREIGN PATENT DOCUMENTS Document Number Date Classification Name Country Country Code-Number-Kind Code MM-YYYY G06F 17/60 Shioda et al. JP 2003-203121 A 07-2003 Japan N 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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